## Application/Control No. Applicant(s)/Patent Under Reexamination 10/757,484 LIN, YI-LAN Notice of References Cited Examiner Art Unit Page 1 of 1 2684 Dominic E. Rego

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,917,824	07-2005	Kobayashi, Fumiyuki	455/575.3
*	В	US-5,923,751	07-1999	Ohtsuka et al.	379/433.13
*	С	US-6,292,980	09-2001	Yi et al.	16/303
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0	,				
	Ρ					
	α			•		·
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.